

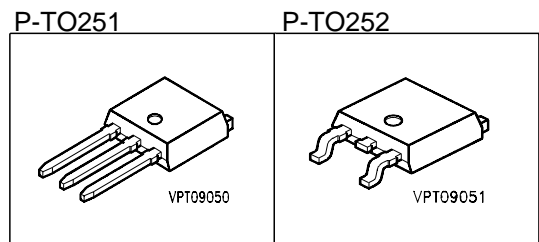
Cool MOS™ Power Transistor

Feature

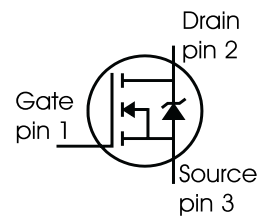
- New revolutionary high voltage technology
- Worldwide best $R_{DS(on)}$ in TO-251 and TO-252
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- Ultra low effective capacitances
- Improved noise immunity

Product Summary

| | | |
|--------------|-----|----------|
| V_{DS} | 600 | V |
| $R_{DS(on)}$ | 0.6 | Ω |
| I_D | 7.3 | A |



| Type | Package | Ordering Code | Marking |
|------------|---------|---------------|---------|
| SPD07N60C2 | P-TO252 | Q67040-S4312 | 07N60C2 |
| SPU07N60C2 | P-TO251 | Q67040-S4311 | 07N60C2 |



Maximum Ratings, at $T_C = 25^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Value | Unit |
|--|----------------|-------------|------------------|
| Continuous drain current $T_C = 25^\circ\text{C}$ $T_C = 100^\circ\text{C}$ | I_D | 7.3 4.6 | A |
| Pulsed drain current, t_p limited by T_{jmax} | $I_{D\ puls}$ | 14.6 | |
| Avalanche energy, single pulse $I_D=5.5\text{A}, V_{DD}=50\text{V}$ | E_{AS} | 230 | mJ |
| Avalanche energy, repetitive t_{AR} limited by T_{jmax} ¹⁾ $I_D=7.3\text{A}, V_{DD}=50\text{V}$ | E_{AR} | 0.5 | |
| Avalanche current, repetitive t_{AR} limited by T_{jmax} | I_{AR} | 7.3 | A |
| Reverse diode dv/dt $I_S=7.3\text{A}, V_{DS} < V_{DD}, di/dt=100\text{A}/\mu\text{s}, T_{jmax}=150^\circ\text{C}$ | dv/dt | 6 | V/ns |
| Gate source voltage | V_{GS} | ± 20 | V |
| Power dissipation, $T_C = 25^\circ\text{C}$ | P_{tot} | 83 | W |
| Operating and storage temperature | T_j, T_{stg} | -55... +150 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Values | | | Unit |
|---|------------|--------|------|----------|------|
| | | min. | typ. | max. | |
| Characteristics | | | | | |
| Thermal resistance, junction - case | R_{thJC} | - | - | 1.5 | K/W |
| Thermal resistance, junction - ambient, leaded | R_{thJA} | - | - | 75 | |
| SMD version, device on PCB: @ min. footprint @ 6 cm ² cooling area ²⁾ | R_{thJA} | - | - | 75 50 | |
| Linear derating factor | | - | - | 0.66 | W/K |
| Soldering temperature, 1.6 mm (0.063 in.) from case for 10s | T_{sold} | - | - | 260 | °C |

Electrical Characteristics, at $T_j = 25\text{ °C}$, unless otherwise specified

Static Characteristics

| | | | | | |
|--|---------------|-----|------|-----|----------|
| Drain-source breakdown voltage $V_{GS}=0V, I_D=0.25mA$ | $V_{(BR)DSS}$ | 600 | - | - | V |
| Drain-source avalanche breakdown voltage $V_{GS}=0V, I_D=7.3A$ | $V_{(BR)DS}$ | - | 700 | - | |
| Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=350\mu A$ | $V_{GS(th)}$ | 3.5 | 4.5 | 5.5 | |
| Zero gate voltage drain current $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}, T_j = 25\text{ °C}$ $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}, T_j = 150\text{ °C}$ | I_{DSS} | - | 0.1 | 1 | μA |
| | | - | - | 100 | |
| Gate-source leakage current $V_{GS}=20V, V_{DS}=0V$ | I_{GSS} | - | - | 100 | nA |
| Drain-source on-state resistance $V_{GS}=10V, I_D=4.6A, T_j=25\text{ °C}$ | $R_{DS(on)}$ | - | 0.54 | 0.6 | Ω |
| Gate input resistance $f = 1\text{ MHz}, \text{open drain}$ | R_G | - | 0.8 | - | |

¹ Repetitive avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR} \cdot f$.

² Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics , at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Values | | | Unit |
|--|--------------|--|--------|------|------|------|
| | | | min. | typ. | max. | |
| Characteristics | | | | | | |
| Transconductance | g_{fs} | $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ $I_D = 4.6\text{A}$ | - | 4 | - | S |
| Input capacitance | C_{iss} | $V_{GS} = 0\text{V}$, $V_{DS} = 25\text{V}$, | - | 970 | - | pF |
| Output capacitance | C_{oss} | $f = 1\text{MHz}$ | - | 370 | - | |
| Reverse transfer capacitance | C_{rss} | | - | 10 | - | |
| Effective output capacitance, 1) energy related | $C_{o(er)}$ | $V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V}$ to 480V | - | 30 | - | pF |
| Effective output capacitance, 2) time related | $C_{o(tr)}$ | | - | 55 | - | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD} = 380\text{V}$, $V_{GS} = 0/13\text{V}$, | - | 11 | - | ns |
| Rise time | t_r | $I_D = 7.3\text{A}$, $R_G = 12\Omega$, | - | 33 | - | |
| Turn-off delay time | $t_{d(off)}$ | $T_j = 125^\circ\text{C}$ | - | 47 | 70 | |
| Fall time | t_f | | - | 9 | 13.5 | |

Gate Charge Characteristics

| | | | | | | |
|-----------------------|-----------------|--|---|------|----|----|
| Gate to source charge | Q_{gs} | $V_{DD} = 350\text{V}$, $I_D = 7.3\text{A}$ | - | 7.5 | - | nC |
| Gate to drain charge | Q_{gd} | | - | 16.5 | - | |
| Gate charge total | Q_g | $V_{DD} = 350\text{V}$, $I_D = 7.3\text{A}$, $V_{GS} = 0$ to 10V | - | 27 | 35 | |
| Gate plateau voltage | $V_{(plateau)}$ | $V_{DD} = 350\text{V}$, $I_D = 7.3\text{A}$ | - | 8 | - | V |

¹ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

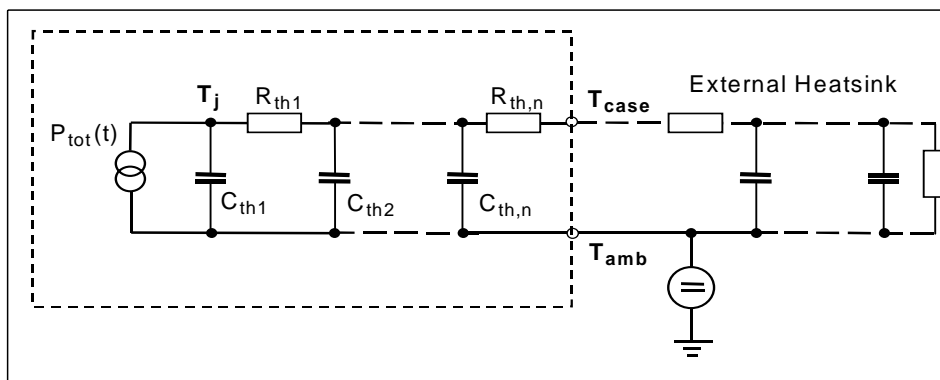
² $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Values | | | Unit |
|---|--------------|-----------------------------------|--------|------|------|------------------------|
| | | | min. | typ. | max. | |
| Characteristics | | | | | | |
| Inverse diode continuous forward current | I_S | $T_C=25^\circ\text{C}$ | - | - | 7.3 | A |
| Inverse diode direct current, pulsed | I_{SM} | | - | - | 14.6 | |
| Inverse diode forward voltage | V_{SD} | $V_{GS}=0\text{V}, I_F=I_S$ | - | 1 | 1.2 | V |
| Reverse recovery time | t_{rr} | $V_R=350\text{V}, I_F=I_S,$ | - | 750 | 1275 | ns |
| Reverse recovery charge | Q_{rr} | $di_F/dt=100\text{A}/\mu\text{s}$ | - | 4.9 | - | μC |
| Peak reverse recovery current | I_{rrm} | | - | 18 | - | A |
| Peak rate of fall of reverse recovery current | di_{rr}/dt | | - | 550 | - | $\text{A}/\mu\text{s}$ |

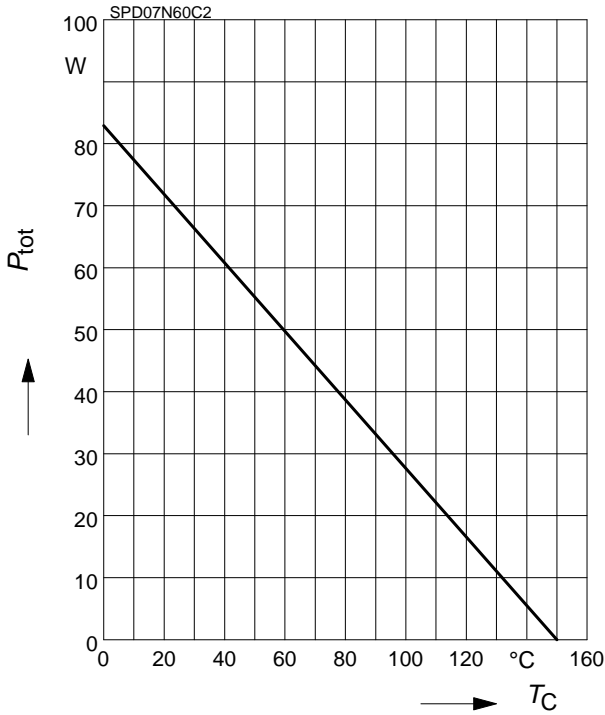
Typical Transient Thermal Characteristics

| Symbol | Value | Unit | Symbol | Value | Unit |
|--------------------|-------|------|---------------------|-----------|------|
| | typ. | | | typ. | |
| Thermal resistance | | | Thermal capacitance | | |
| R_{th1} | 0.024 | K/W | C_{th1} | 0.0001354 | Ws/K |
| R_{th2} | 0.052 | | C_{th2} | 0.0004561 | |
| R_{th3} | 0.065 | | C_{th3} | 0.0007717 | |
| R_{th4} | 0.172 | | C_{th4} | 0.001013 | |
| R_{th5} | 0.177 | | C_{th5} | 0.00738 | |
| R_{th6} | 0.064 | | C_{th6} | 0.04 | |



1 Power dissipation

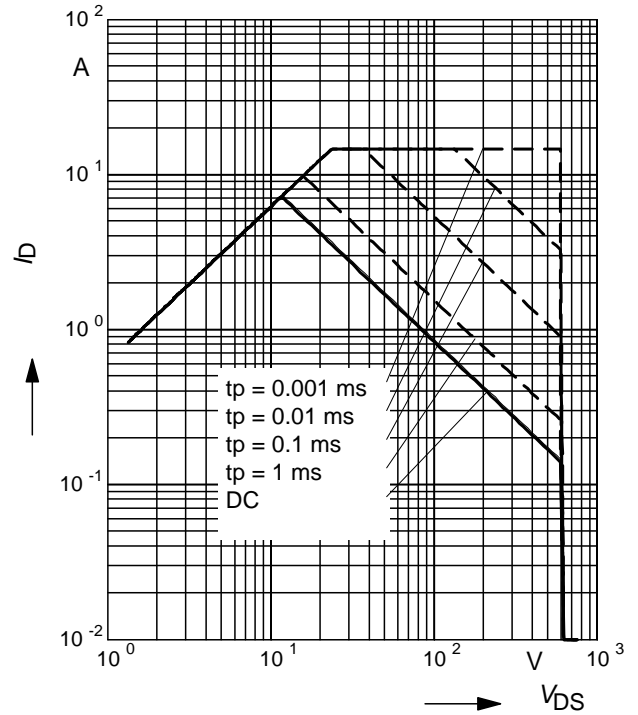
$$P_{tot} = f(T_C)$$



2 Safe operating area

$$I_D = f(V_{DS})$$

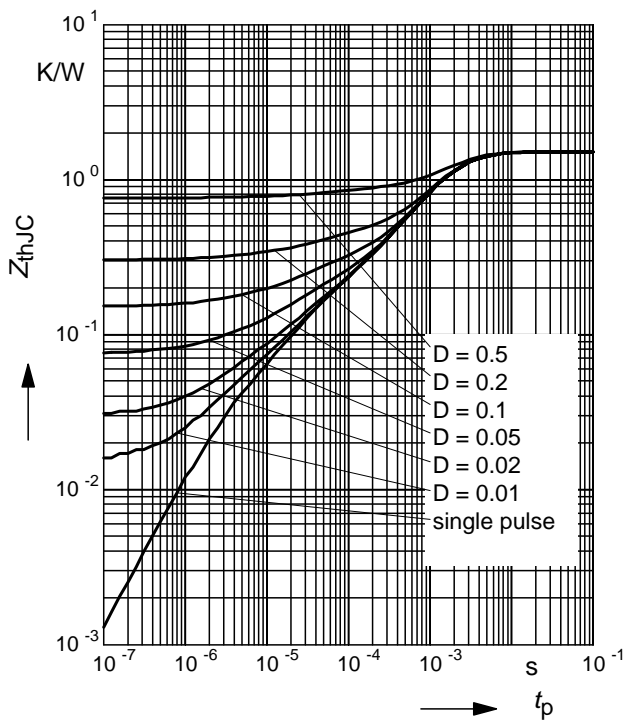
parameter : $D = 0$, $T_C = 25^\circ\text{C}$



3 Transient thermal impedance

$$Z_{thJC} = f(t_p)$$

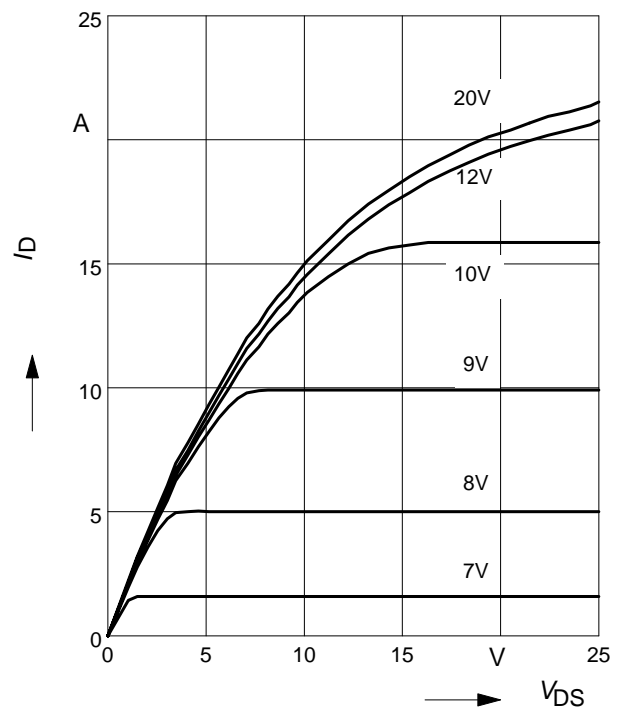
parameter: $D = t_p/T$



4 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

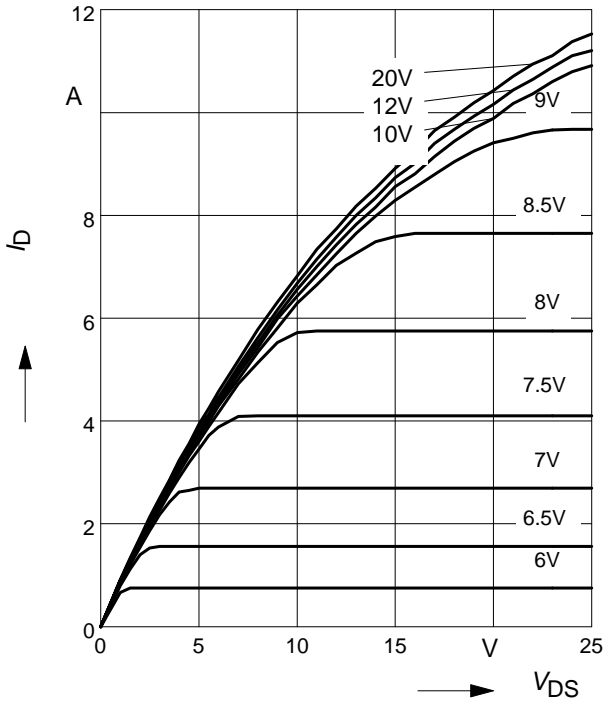
parameter: $t_p = 10 \mu\text{s}$, V_{GS}



5 Typ. output characteristic

$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$

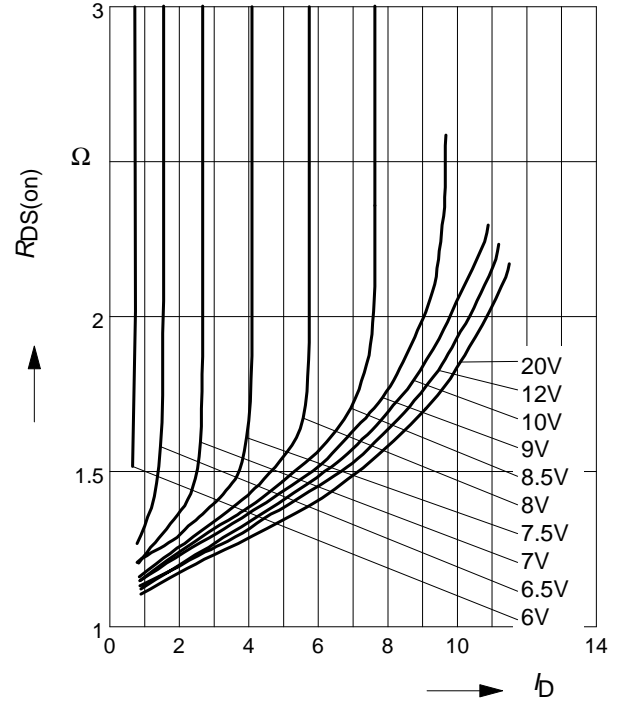
parameter: $t_p = 10 \mu\text{s}, V_{GS}$



6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$

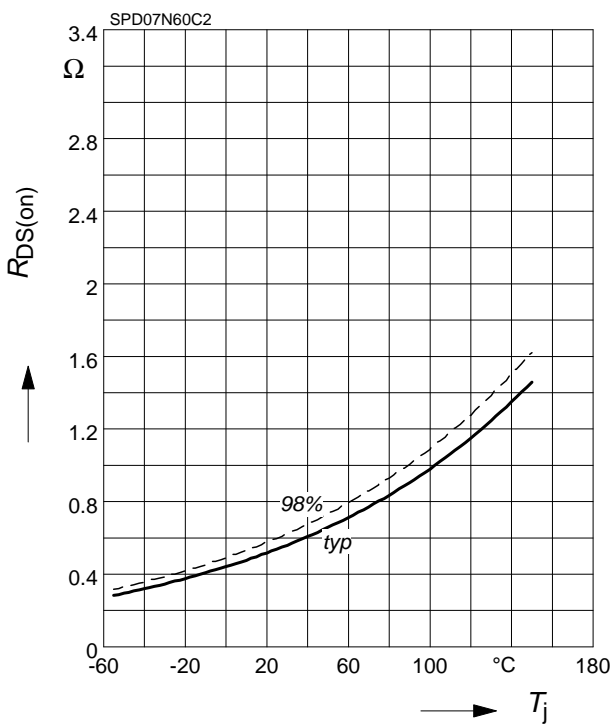
parameter: $T_j = 150^\circ\text{C}, V_{GS}$



7 Drain-source on-state resistance

$R_{DS(on)} = f(T_j)$

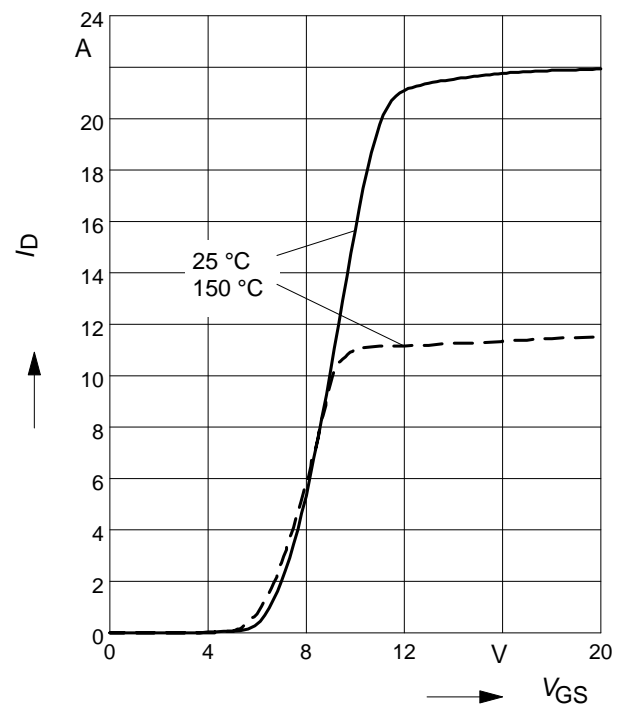
parameter: $I_D = 4.6 \text{ A}, V_{GS} = 10 \text{ V}$



8 Typ. transfer characteristics

$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$

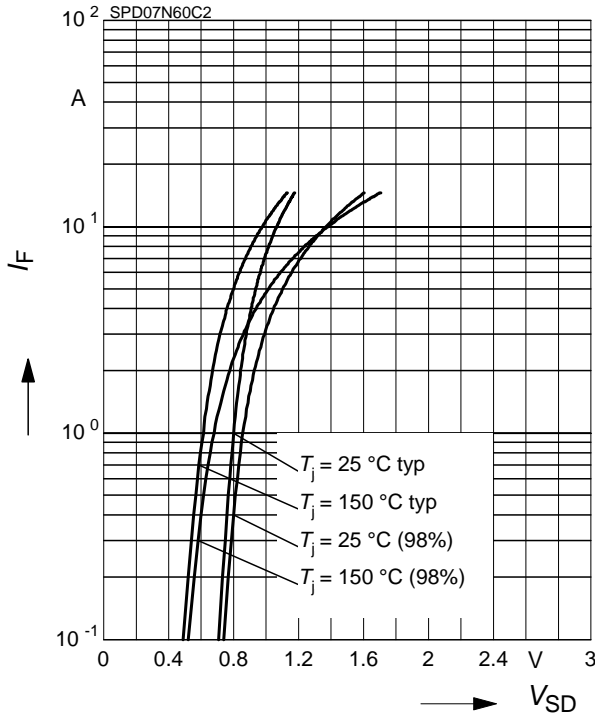
parameter: $t_p = 10 \mu\text{s}$



9 Forward characteristics of body diode

$I_F = f(V_{SD})$

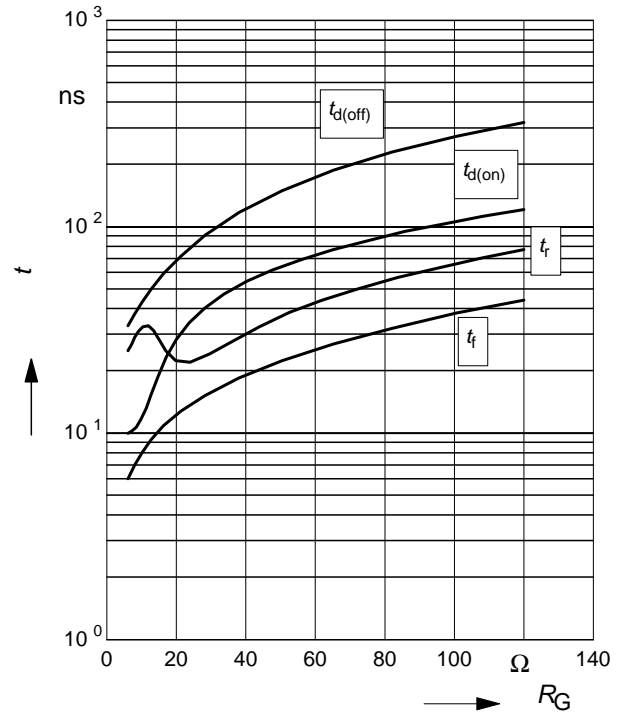
parameter: T_j , $t_p = 10 \mu s$



10 Typ. switching time

$t = f(R_G)$, inductive load, $T_j=125^\circ C$

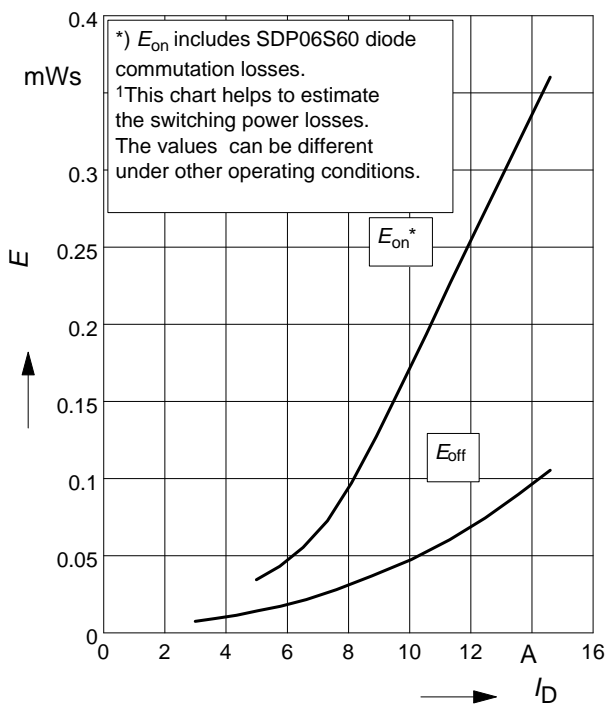
par.: $V_{DS}=380V$, $V_{GS}=0/+13V$, $I_D=7.3 A$



11 Typ. switching losses¹⁾

$E = f(I_D)$, inductive load, $T_j=125^\circ C$

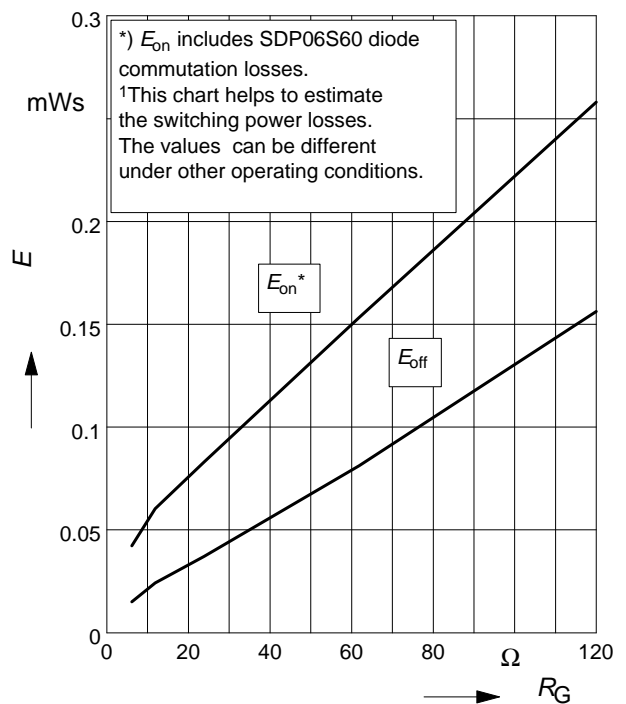
par.: $V_{DS}=380V$, $V_{GS}=0/+13V$, $R_G=12\Omega$



12 Typ. switching losses¹⁾

$E = f(R_G)$, inductive load, $T_j=125^\circ C$

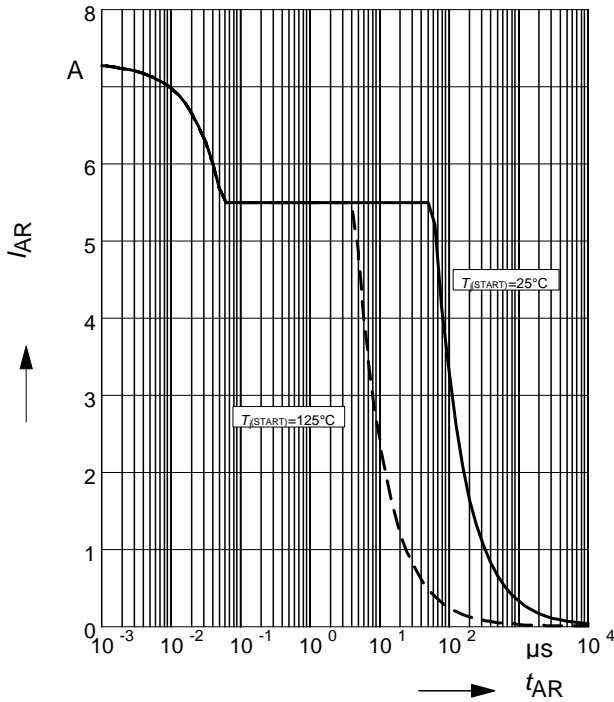
par.: $V_{DS}=380V$, $V_{GS}=0/+13V$, $I_D=7.3A$



13 Avalanche SOA

$$I_{AR} = f(t_{AR})$$

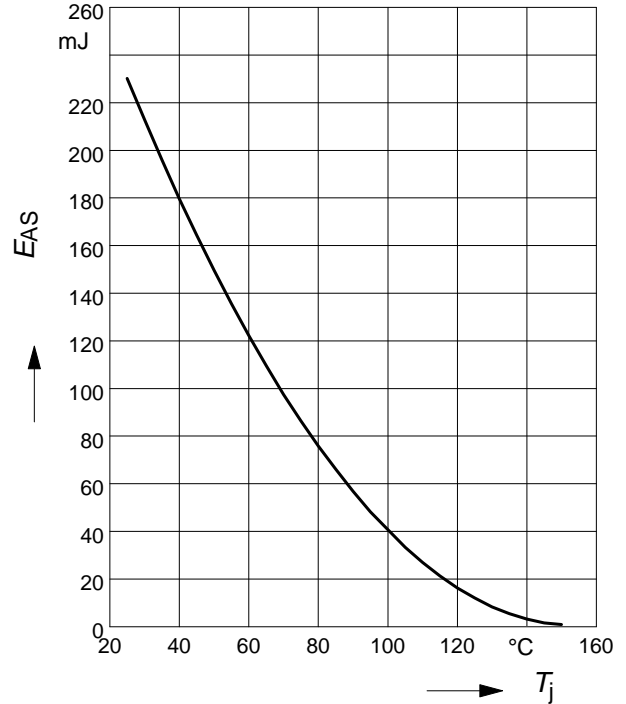
par.: $T_j \leq 150\text{ }^\circ\text{C}$



14 Avalanche energy

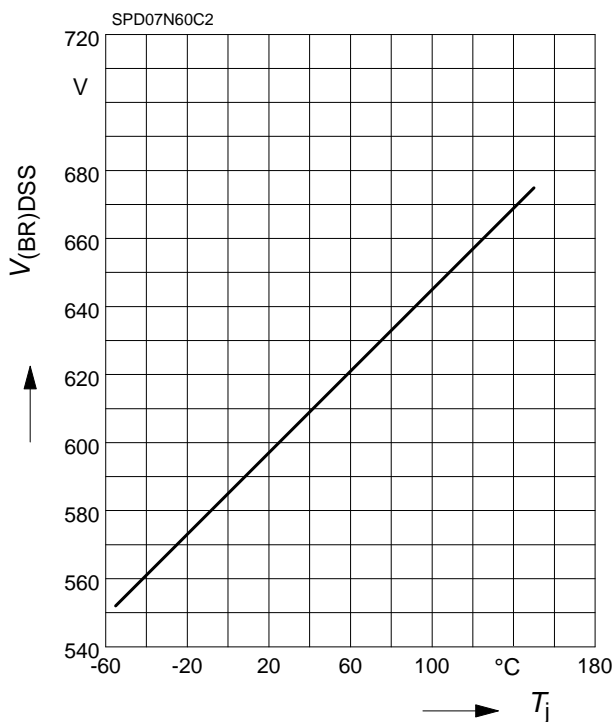
$$E_{AS} = f(T_j)$$

par.: $I_D = 5.5\text{ A}$, $V_{DD} = 50\text{ V}$



15 Drain-source breakdown voltage

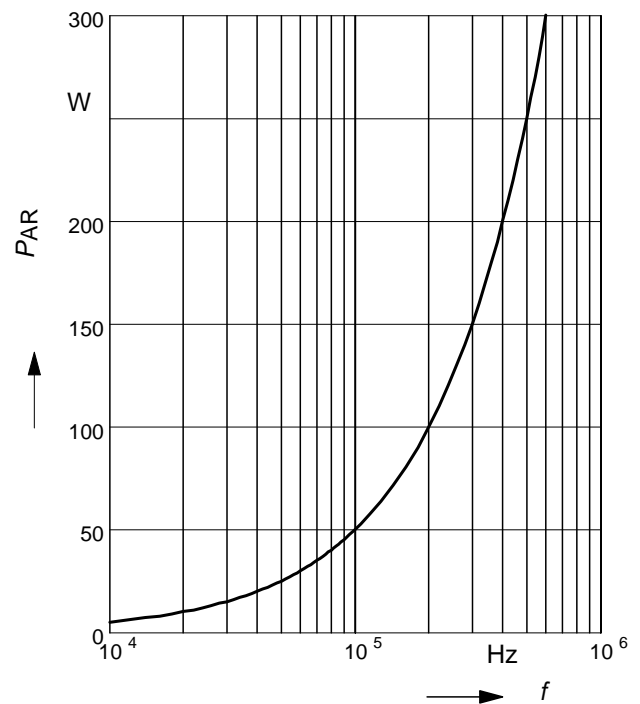
$$V_{(BR)DSS} = f(T_j)$$



16 Avalanche power losses

$$P_{AR} = f(f)$$

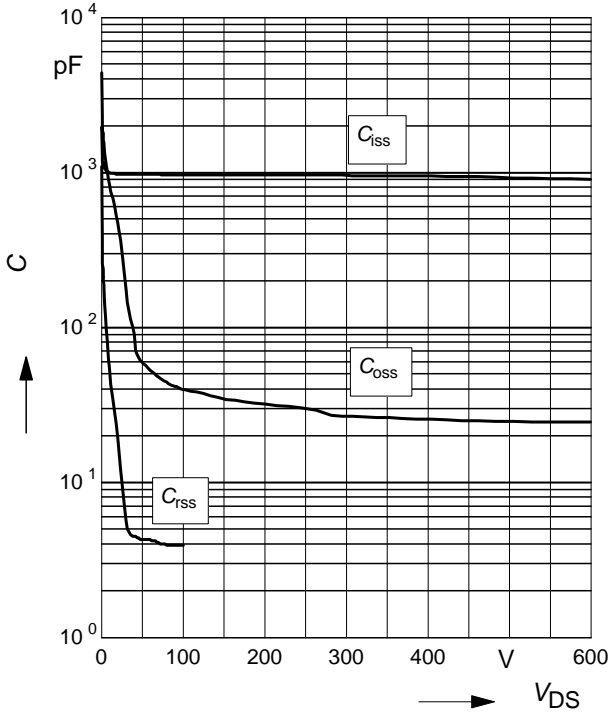
parameter: $E_{AR} = 0.5\text{ mJ}$



17 Typ. capacitances

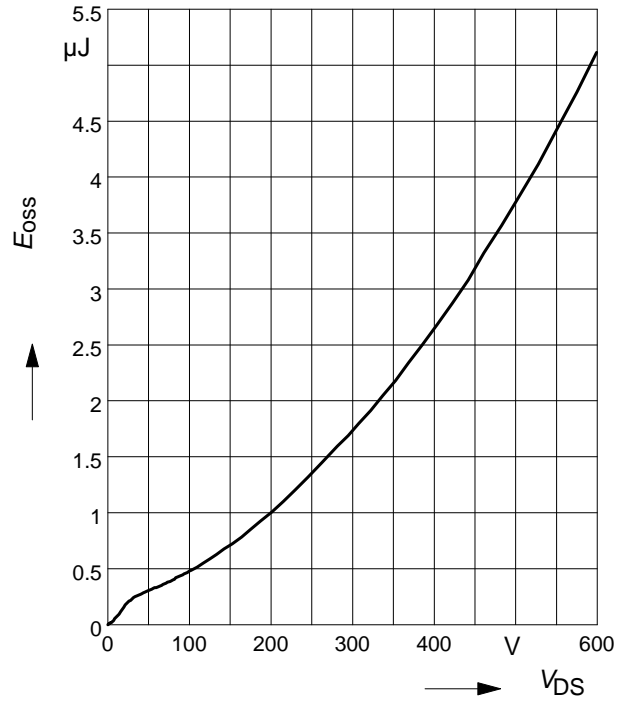
$C = f(V_{DS})$

parameter: $V_{GS}=0V, f=1\text{ MHz}$

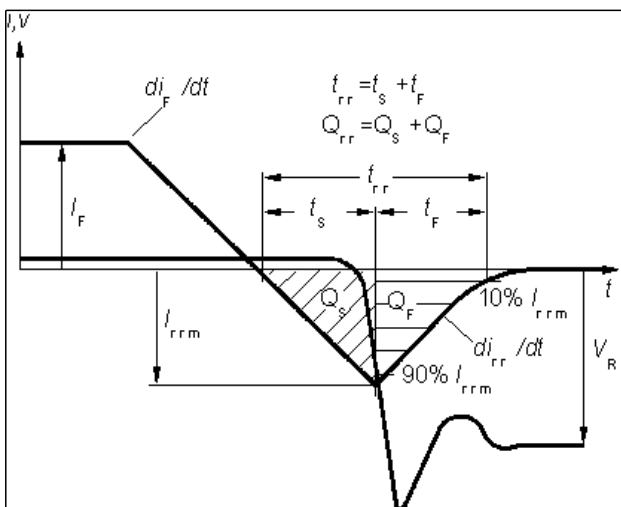


18 Typ. C_{OSS} stored energy

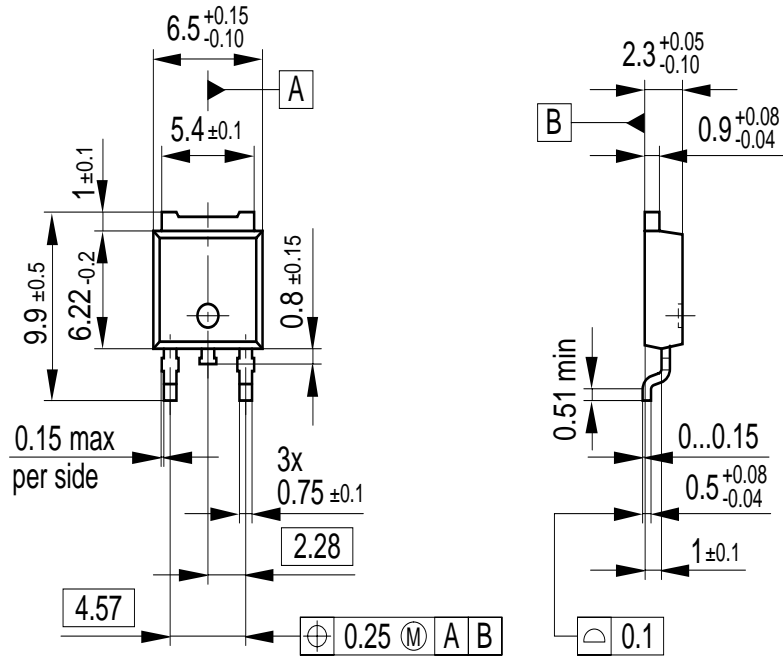
$E_{OSS}=f(V_{DS})$



Definition of diodes switching characteristics



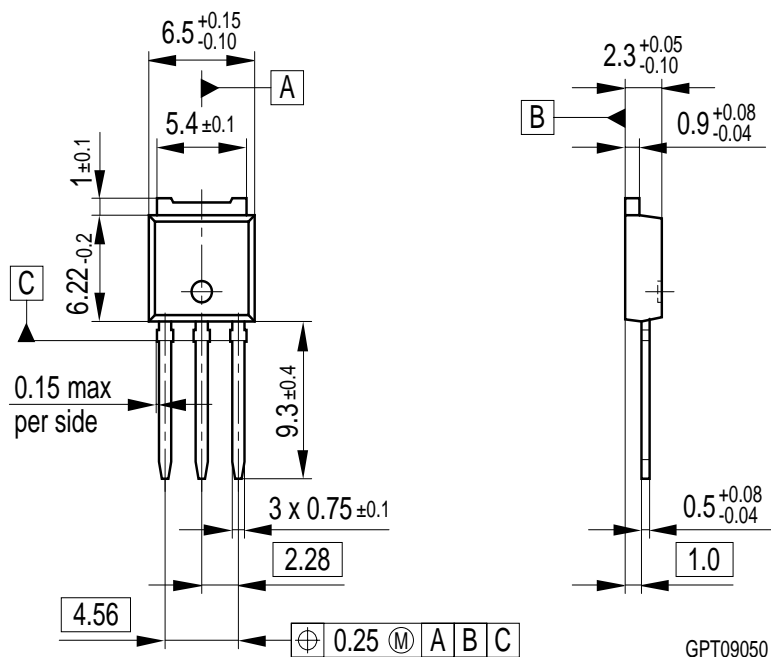
P-TO-252-3-1 (D-PAK)



GPT09051

All metal surfaces tin plated, except area of cut.

P-TO-251-3-1 (I-PAK)



GPT09050

All metal surfaces tin plated, except area of cut.

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